



SVG-4034

1/16

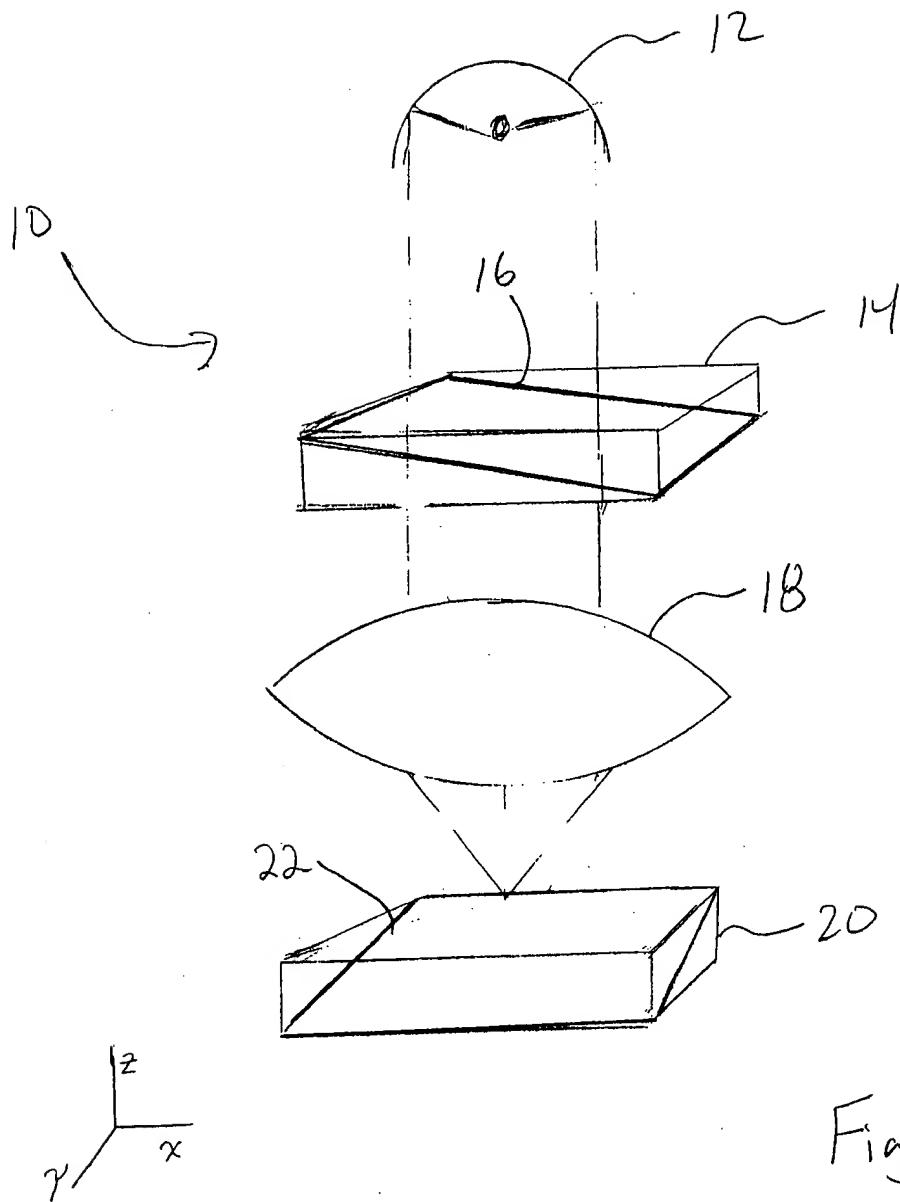


Fig 1



SUG-4034
2/16

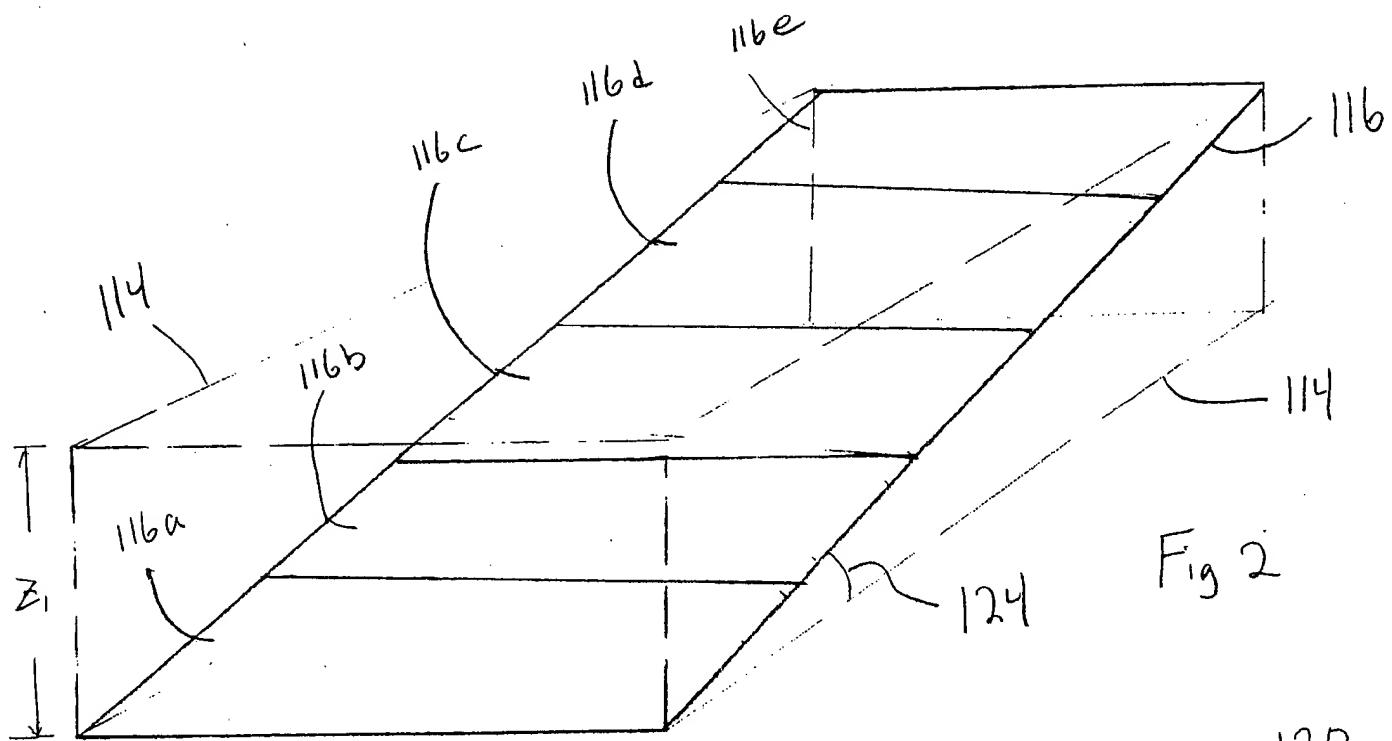


Fig 2

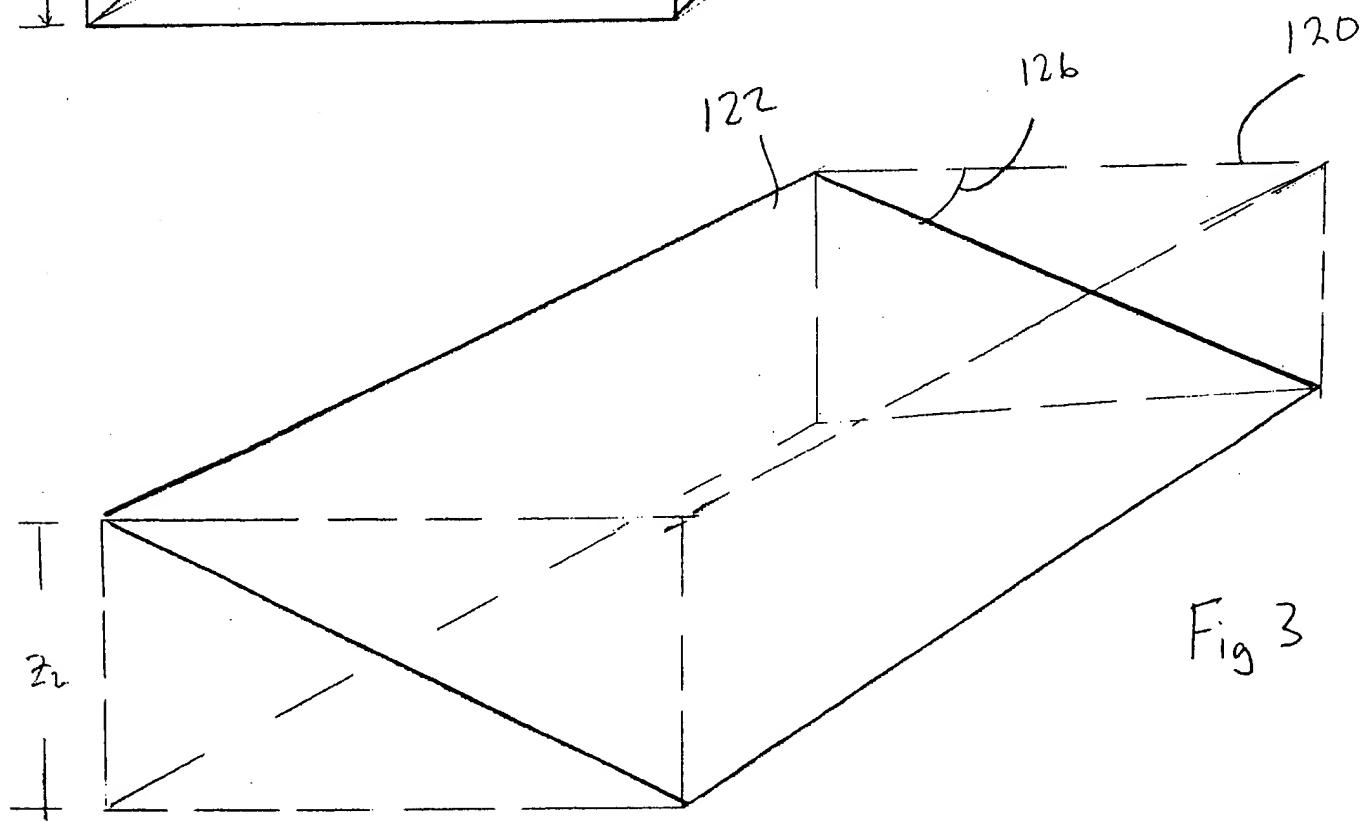


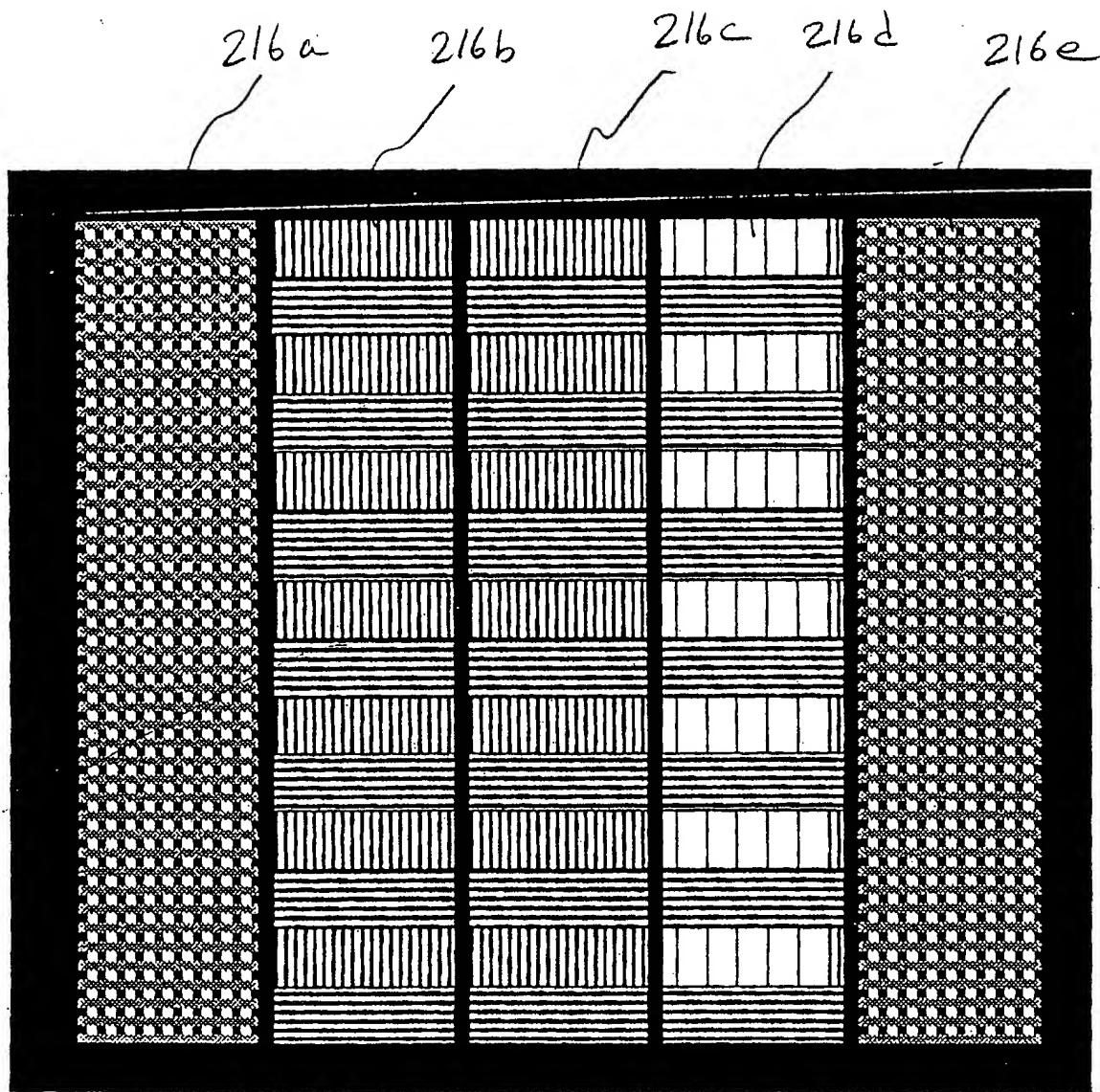
Fig 3



()

()

SV6-4034
3/16



216
↗

Fig 4



C

D

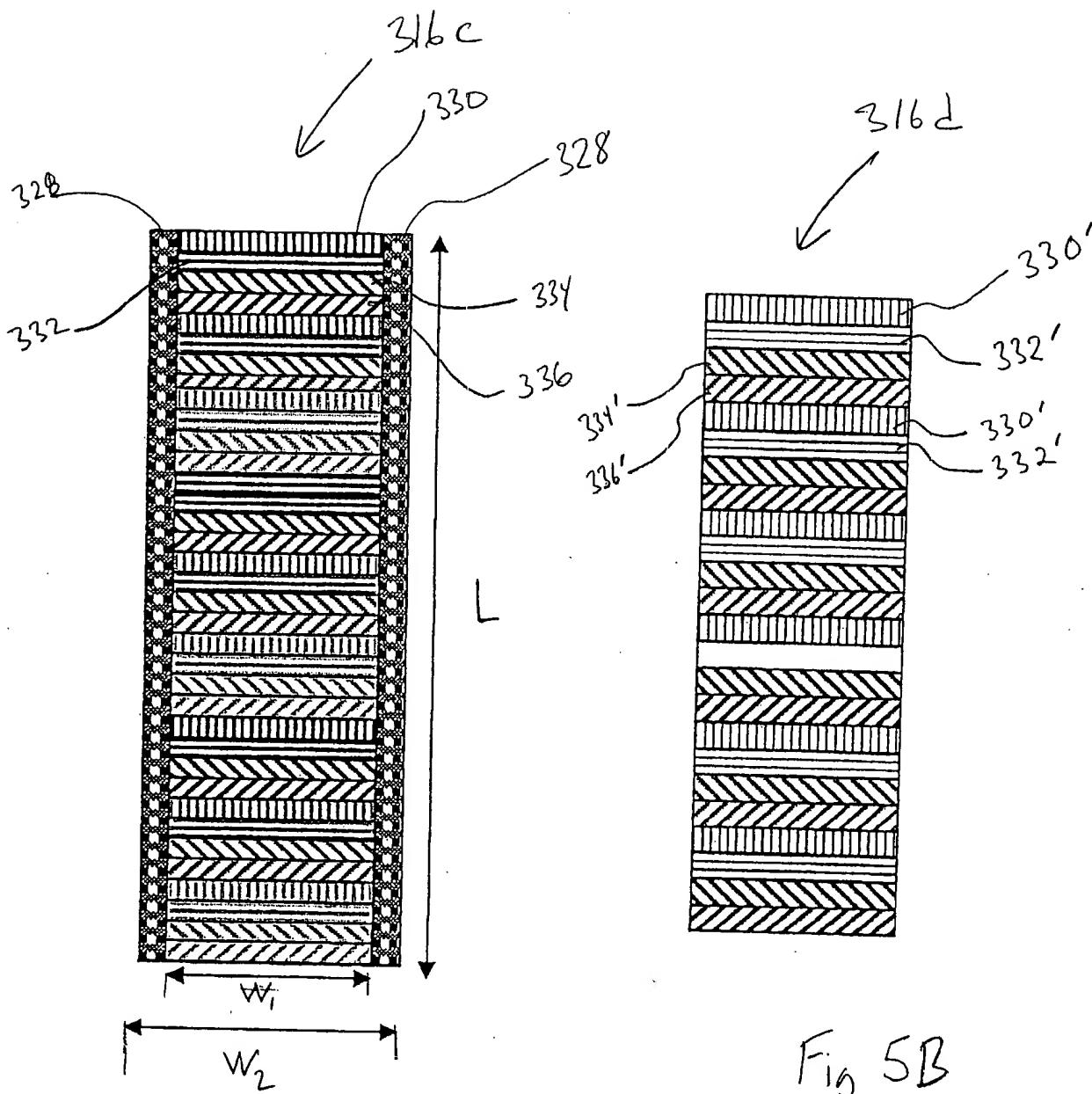
SUG-4034
4/16

Fig 5A

Fig 5B



SV6-4034
S/16

Optical System
characterizer

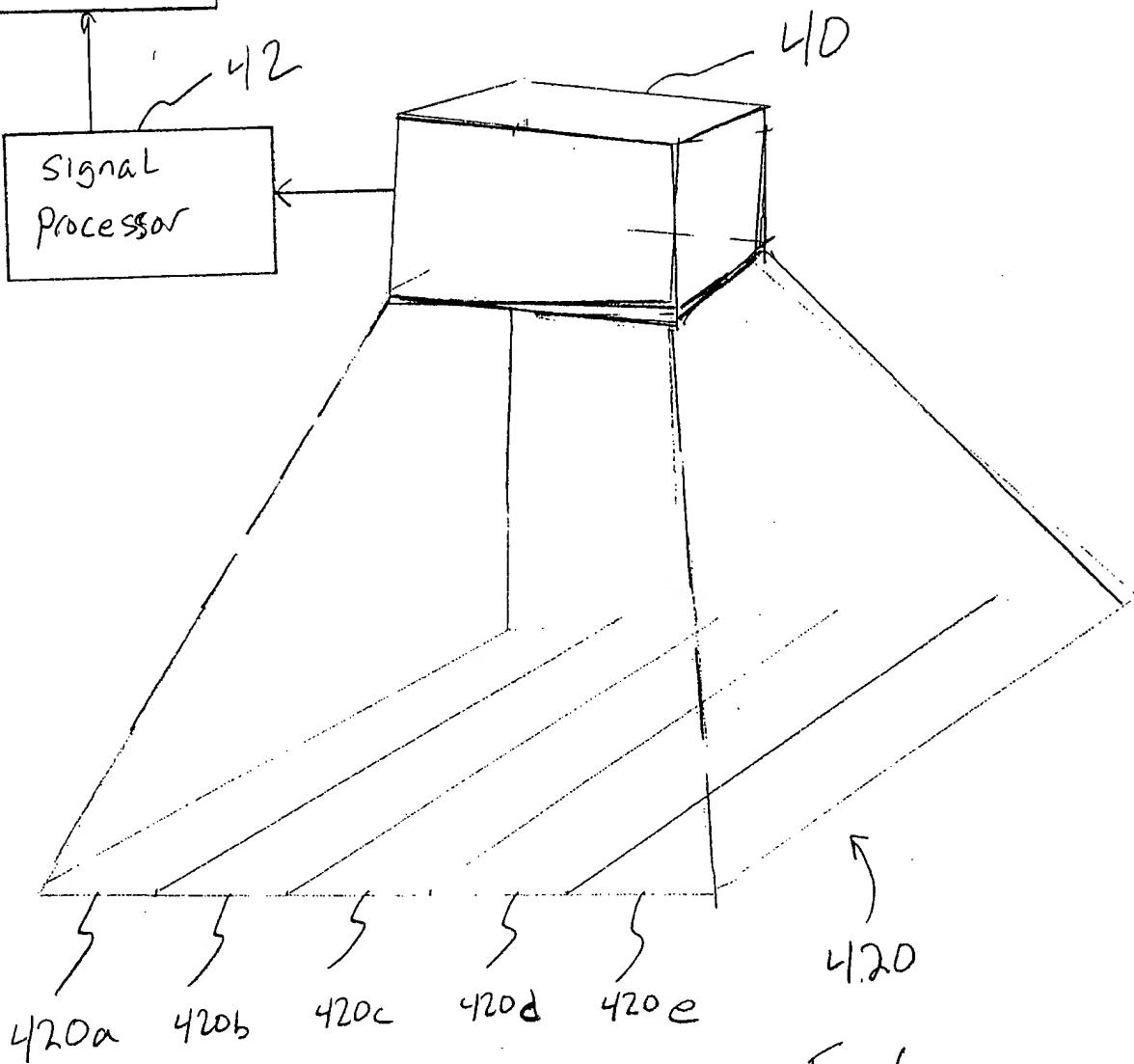


Fig 6



SVG-4034

6/16

IMAGING A RETICLE HAVING A GRATING
THEREON IN A PLANE OBLIQUE TO THE
RETICLE PLANE WITH AN OPTICAL
SYSTEM

510

RECORDING DATA REPRESENTING THE
IMAGE OF THE GRATING

512

INTERFEROMETRICALLY ANALYZING
THE RECORDED DATA DETERMINING
IMAGING PROPERTIES OF THE OPTICAL
SYSTEM

514

FIG. 7



SUL-4034

7/16

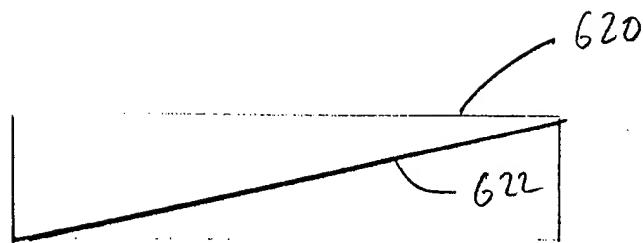


Fig 8A

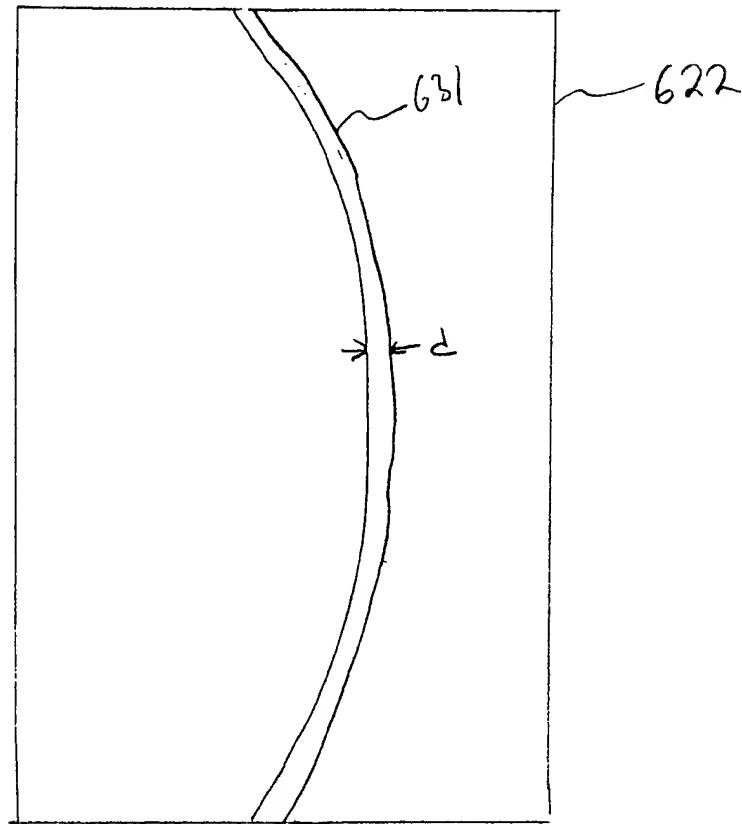


Fig 8B



SVL-4034

8/16

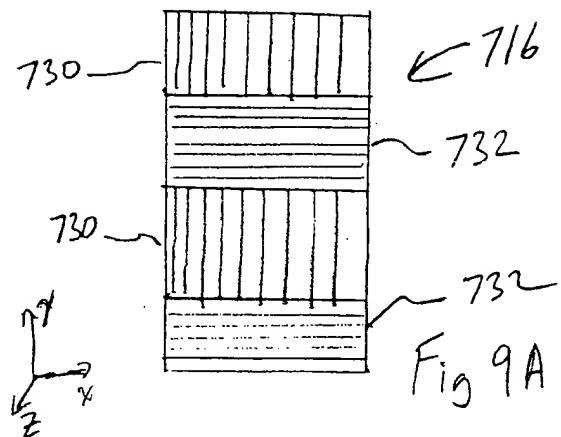


Fig 9A

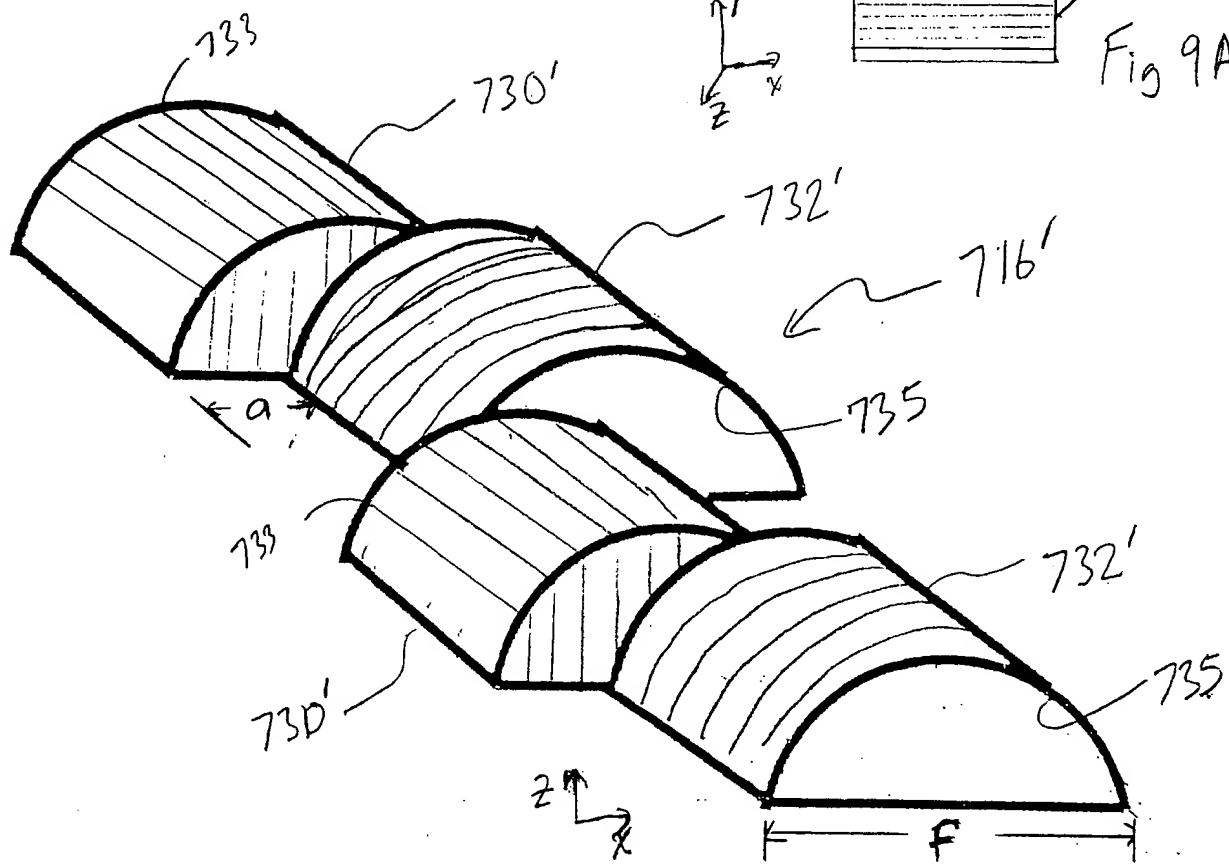


Fig 9B



SV6-4034
9/15

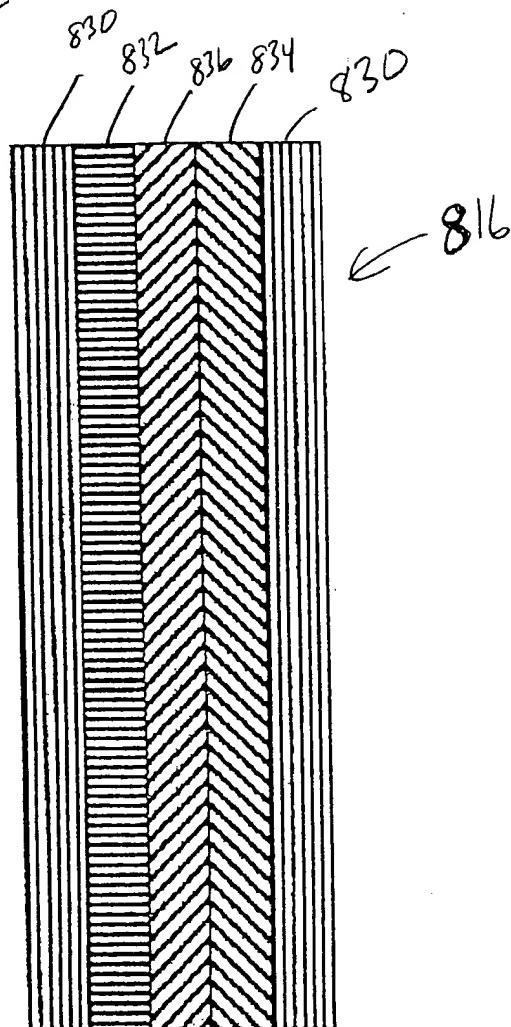


Fig 10A

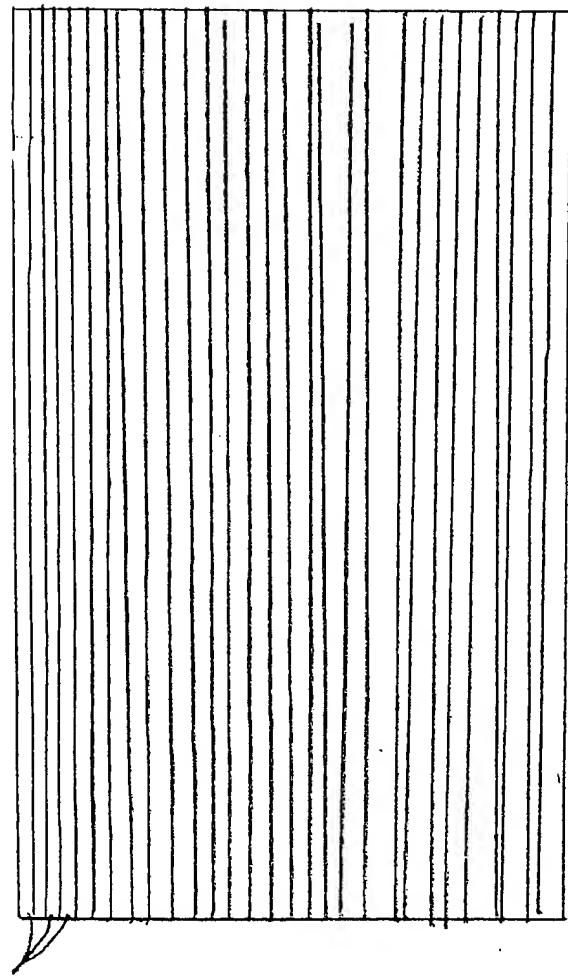


Fig 10B

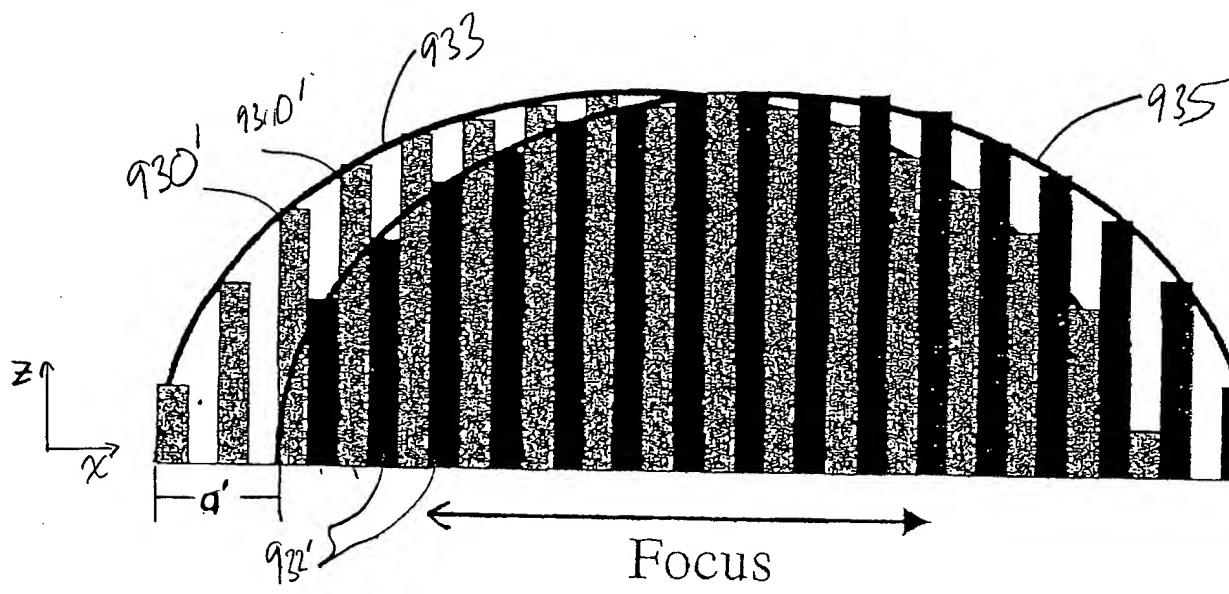
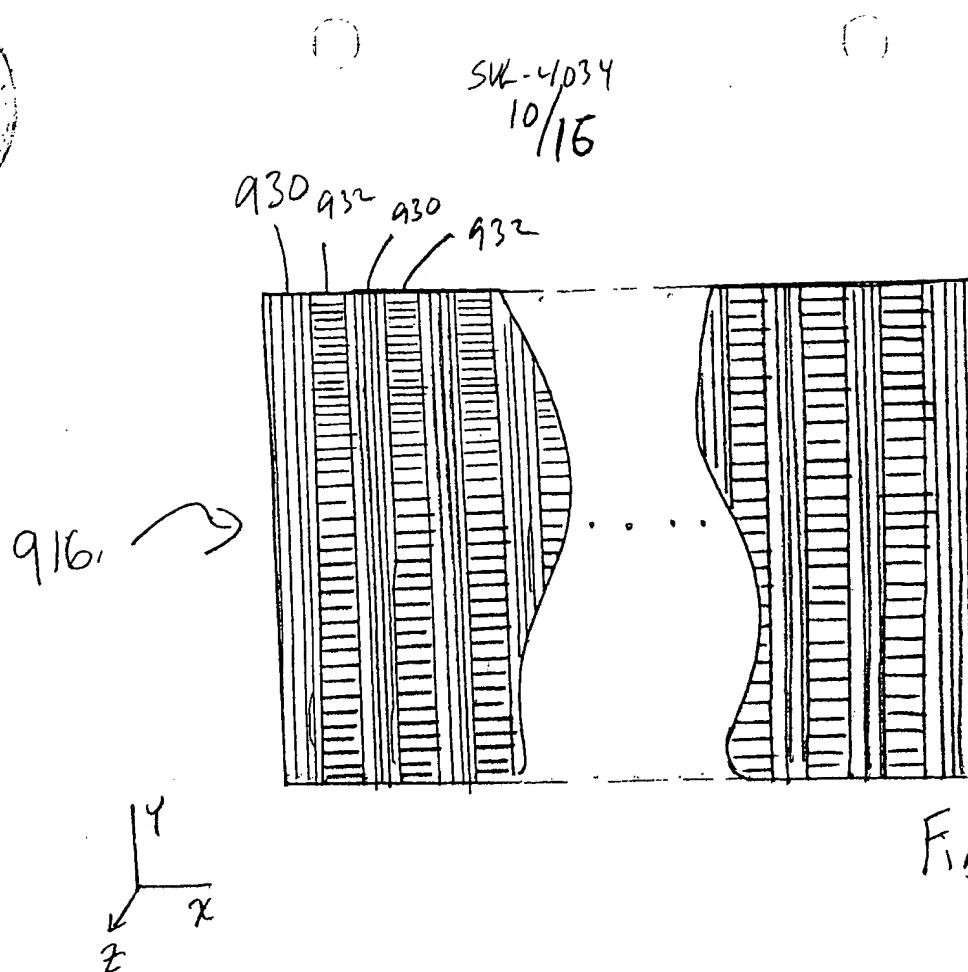


Fig 11B



SVL-4034

11/16

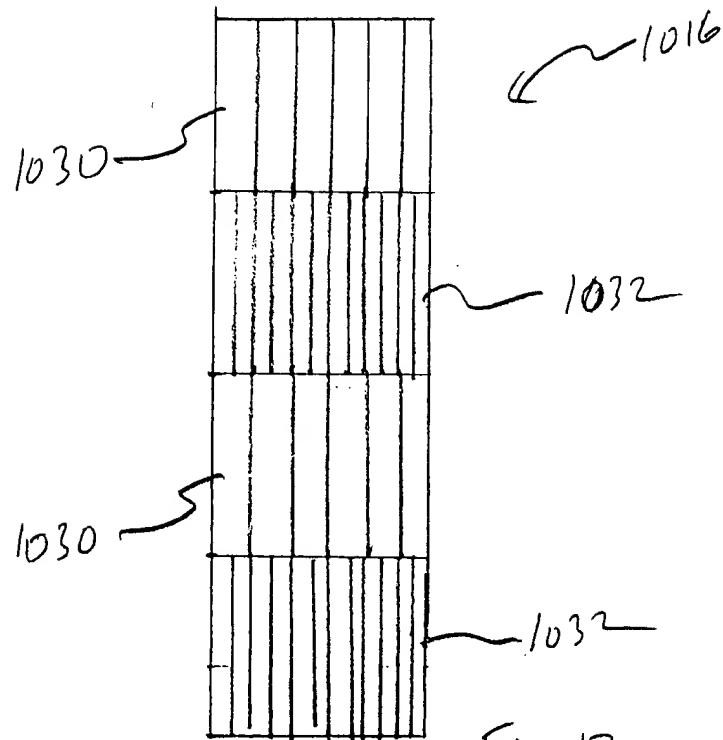
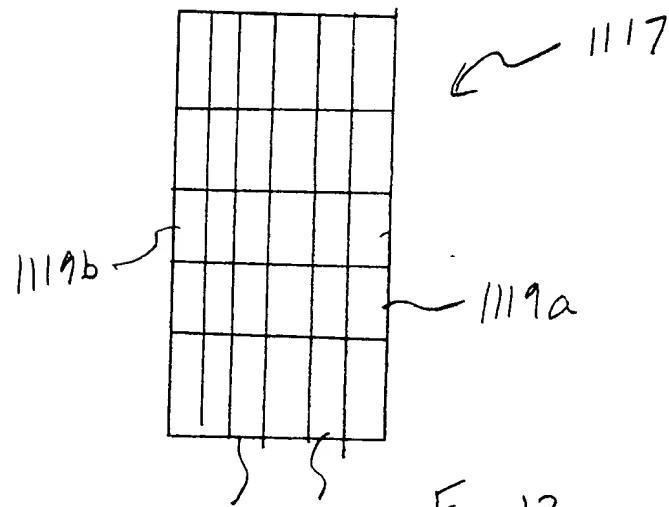


Fig 12



1119c 1119d Fig 13



SV6-4034

12/16

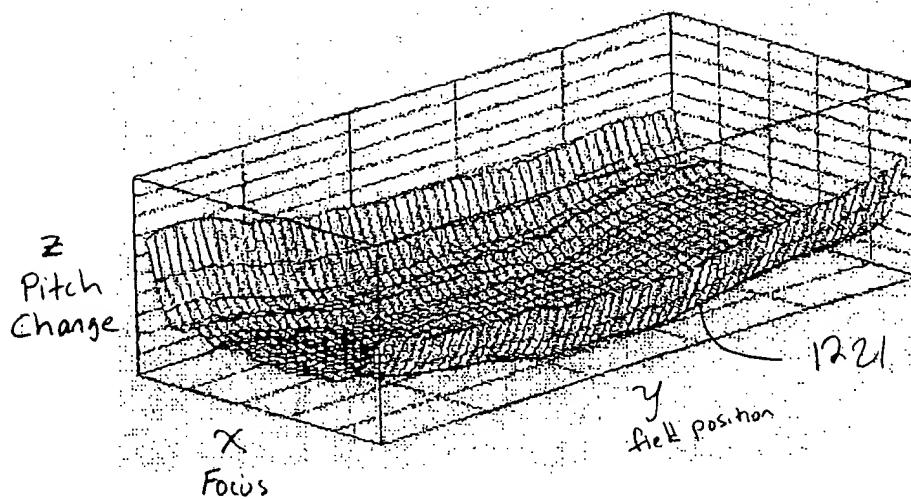


Fig 14

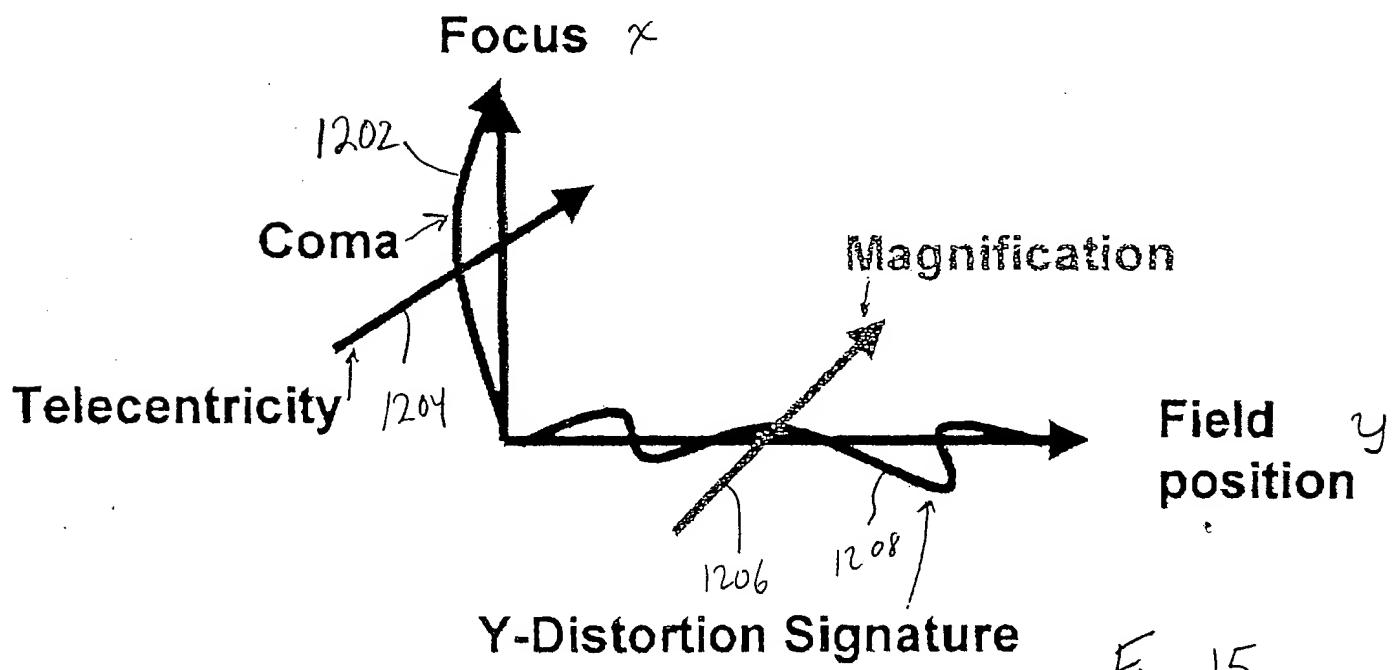


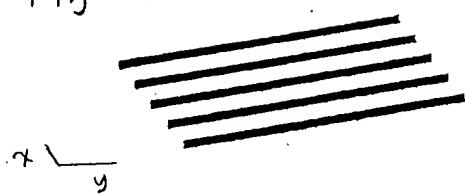
Fig 15



SVL-4034

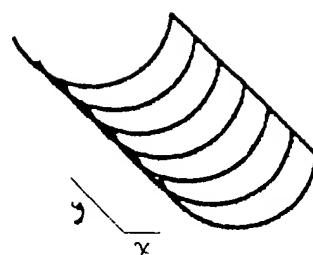
13/16

Fig 16A



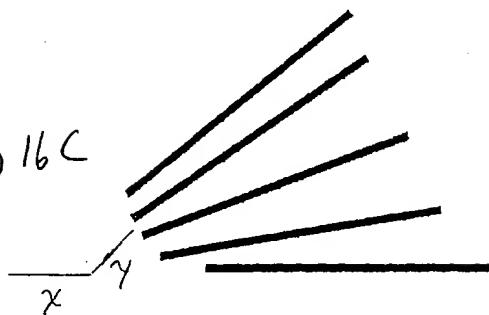
Magnification

Fig 16B



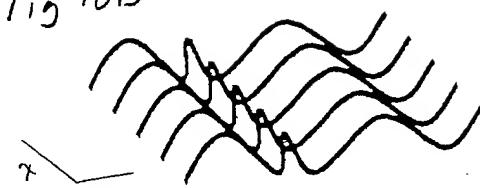
Coma

Fig 16C



Telecentricity

Fig 16D



Y-Distortion Signature



SVL-4034

14/16

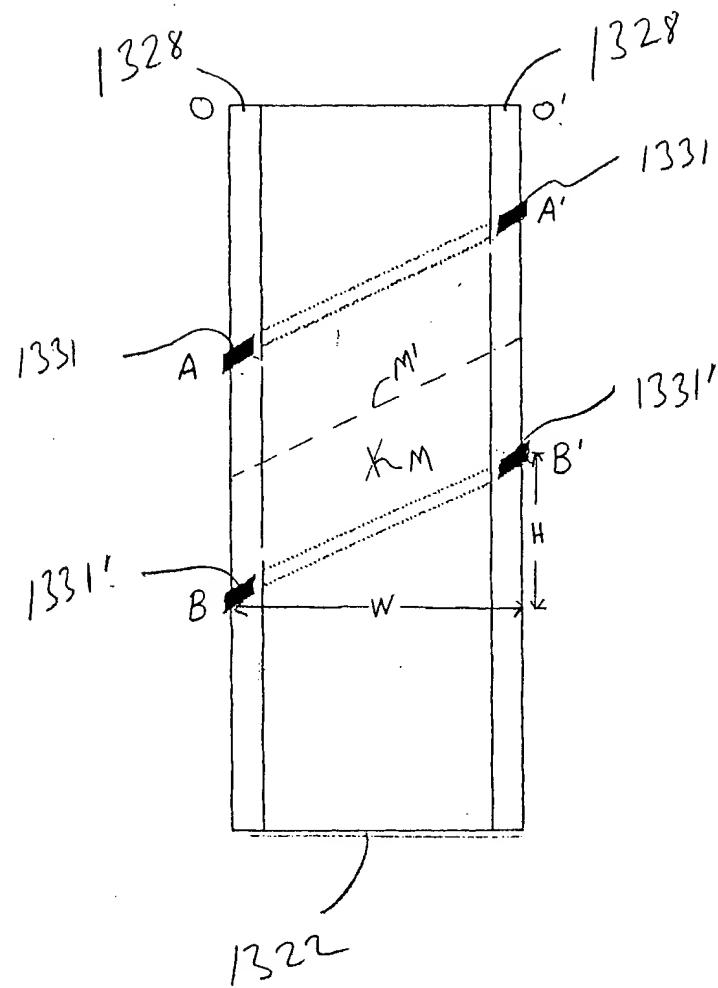


Fig. 17



SV6-4034

15/16

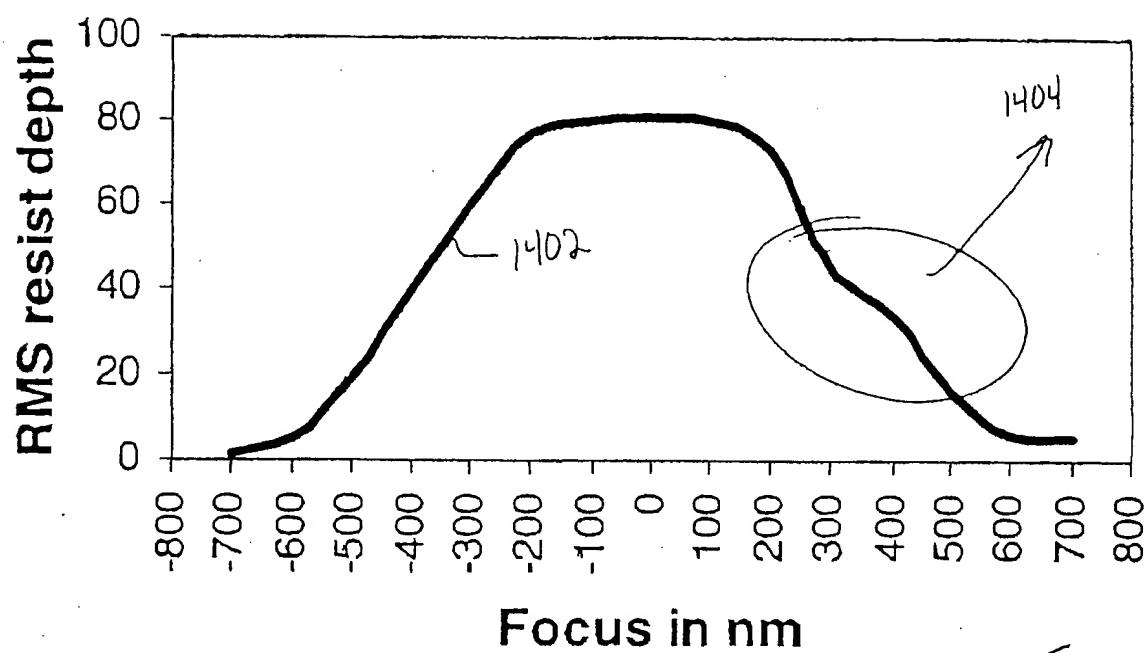


Fig. 18



SUL-4034

16/16

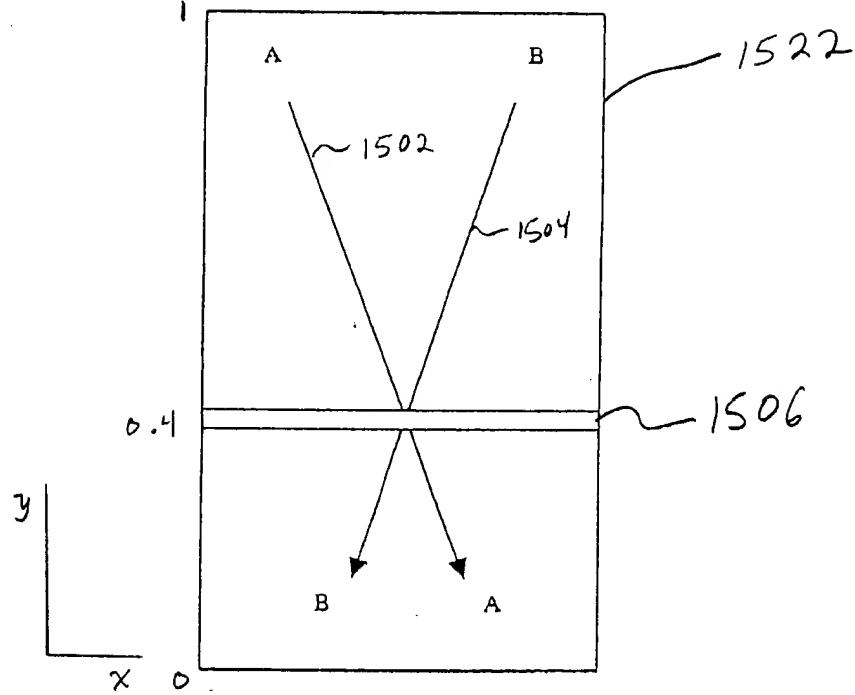


Fig. 19A

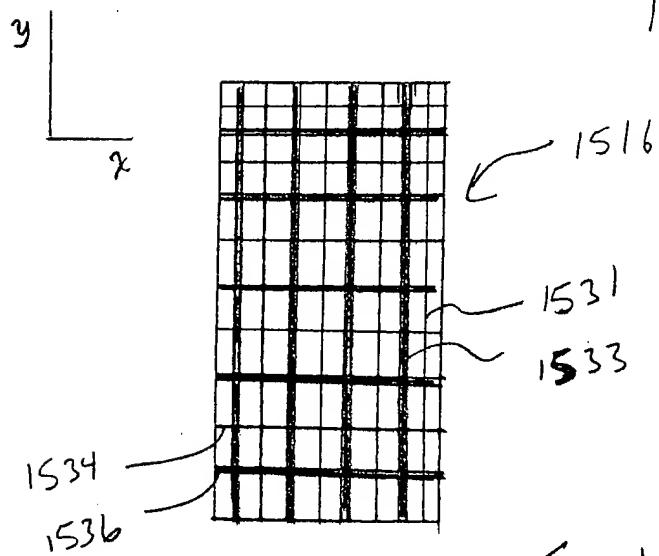


Fig 19B